Application/Control No. Applicant(s)/Patent Under Reexamination 10/667,666 CHEN ET AL. Notice of References Cited Examiner Art Unit Marc S. Zimmer Page 1 of 1 1712 U.S. PATENT DOCUMENTS Document Number Date Country Code-Number-Kind Code MM-YYYY Name Classification Α US-6011123 01-2000 Kurosawa et al. 525/431 В US-5962113 10-1999 Brown et al. 428/209 С US-US-D Е US-F US-G US-Н US-1 US-US-J Κ US-L US-М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Code-Number-Kind Code Country MM-YYYY Name Classification JP 4-189866 A 07-1992 Japan Aoki et al. C08I 79/08 0 Ρ Q R s

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